

ELECTRON DIFFRACTION STUDY OF CuGaS₂ FILM

Abstract

In present work, the results of electron diffraction investigations of structures of amorphous thin films of CuGaS₂ have been given and function of radial distribution of atoms (FRDA) has been calculated. Appropriate coordination number $n=4,1$ we obtained from calculating the area under the first peak, also indicates tetrahedral surrounded by atoms of copper and gallium. During the deposition of this ternary compound on a substrate with $T = 423-433$ K the mixture of polycrystalline single crystal is formed. With the increase of temperature the intensity of polycrystallines decreases and point reflections according to the monocrystal increases. Further increase of the substrate temperature to 453 K LiF leads to the formation of a perfect single crystal.

Superstructure phase CuGaS₂ is oriented on (100) plane parallel to the faces LiF. During epitaxial growth on LiF CuGaS₂ one unit cell superstructure is mated with four cells of the substrate. Between periods of lattices of the initial phase and superstructure there are simple relations common with: $a \approx 3a_0$; $c \approx 2c_0$.

Keywords. Diffraction, phase, atoms, structure, superstructure, amorphous, compositions

1.Introduction.

A number of works [1-3] were devoted to X-ray studies of crystalline structures of the compounds of group A¹-B³-C⁶. However in none of the known works

patterns of short range order structure of amorphous compositions CuGaS_2 were determined.

The reason for this can be found either by difficulties in establishing conditions for amorphous films of these compounds, or trends in amorphous films to the more dense packing.

Amorphous thin films CuGaS_2 of thickness 25 nm were obtained by evaporation alloys CuGaS_2 in the vacuum of 10^{-4} PA on the substrate NaCl , KCl

and LiF located at room temperature. NaCl , KCl and LiF ion crystals have been chosen as substrate because by solving these crystals in the water thin CuGaS_2 layers formed on them separating stay on the surface of water and which is kept in the metal net with diameter of 0.1-0.3 mm.

On the other hand these substrates with cubic structure of different elementary cell parameters affect epitoxially on crystallisation in primary formation of condensate and further thermo-processing.

The rate of deposition of films for all cases was the 1 1.5 nm/sec.

Amorphous phase CuGaS_2 is formed until $T_s=383$ K, crystallization, which can lead to the formation of polycrystalline with periods of a tetragonal lattice, military data [5].

Amorphous films formed with values $S=4\pi\sin\theta/\lambda=24.10; 29.50; 53.70; 83,70\text{ nm}^{-1}$ (Fig.1) after heat treatment at $T_s=380$ K are crystallized in the structure of chalcopyrite tetragonal lattice CuGaS_2 with periods $a=0,535$; $c=1.047$ nm, $\text{CBC I } \bar{4} 2d$ [5].

2. Experiment

Parameters of short range order distances of coordination spheres and interatomic distances, coordination

Comment [u1]: This is present work film preparation or standard preparation from previous work? Need reference here!!

numbers (CN) may be determined by the functions of atom radial distribution (FARD)

prepared according to

the retraining Fourier intensity of the coherent scattering of electrons.

$$4\pi r^2 \sum_m K_{mPm}(r) = 4\pi r^2 U_0 \sum_m K_m +$$

$$\frac{2r}{\pi} \sum_m K_m \int_0^\infty St(s) \sin(Sr) dS \quad (1) [12],$$

Here $U_0 = d/Mm_h$ - average density of atoms, d - amorph object density, M - molecular

mass, $m_H = 1.65 \times 10^{-24}$ gr - hydrogen atom mass $\rho_m(r)$ - function of atom density. $S =$

$4\pi \sin \theta / \lambda$ is the half of scattering angle, $K_m^2 = (Z_m / Z_1)$ (8) - scattering capability of

atoms and Z_m - the order number of the atom included in the content of expression, Z_1 -

the order number of lighter atom of the expression in the periodical system.

$$I(S) = \left(\frac{I_h^k(S)}{\sum f_m^2} \right) (S - 1) \sum_m K_m \quad (9) - \text{interference function}.$$

Reliable, (FARD) can only be obtained when integrating from 0 to ∞ or before S_2 , if

interference functions do not feel out of oscillate that occurs in strongly disordered

systems. The intensity of scattering can be determined experimentally with sufficient

accuracy only on some interval of values $S = 4\pi \sin \theta / \lambda$, so practically the integration in

(1) is over a finite interval from S_1 to S_2 .

Comment [u2]: Please provide preparation of amorphous film CuGaS₂ in this section. Author only mentioned the characterization and parameter and simple explanation only require.

3. Results and discussion

Intensity curve electron scattering from amorphous films CuGaS₂ were obtained

on electronography brand EMR-102 in the form of graphs of dependences

of the intensity of scattering angles, i.e. from $S = 4\pi \sin \theta / \lambda$ (Fig.1).

Function $i(S)$

graphically depicted in (Figure 2.), were used to calculate (FARD) for CuGaS₂ (fig. 3.)

Comment [u3]: Fig. 2 instead of Figure 2.

Comment [u4]: Fig. 3 instead of fig. 3.

according to formula (1). The calculation was carried out on the programmer "RADIADIS" on the computer IBM. Intervals of variables accounted for $\Delta r = 0,01 \text{ nm}^{-1}$, $\Delta S = 0,01 \text{ nm}^{-1}$.

(FARD) CuGaS_2 (fig. 3.) contains four asymmetric highs one of which is isolated and a group of false highs, emanating from the larger values of S.

The area under the respective highs, manifesting themselves in $r_1 = 0,234$; $r_2 = 0,244$; $r_3 = 0,282$; $r_4 = 0,411 \text{ nm}$. are equal $\Delta_1 = 16,0$; $\Delta_2 = 20,3$; $\Delta_3 = 55,5$ and $\Delta_4 = 80,0 \text{ nm}$ respectively.

Distance $r_1 = 0,234 \text{ nm}$ revealed on (FARD) CuGaS_2 , is the distance between atoms Cu-S, as tetrahedral covalent radii are equal to $r_{\text{Cu}} = 0,135$ and $r_{\text{S}} = 0,104 \text{ nm}$. Appropriate coordination number $n = 4,1$ obtained from calculating the area under the first peak, also indicates tetrahedral surrounded by atoms of copper and gallium.

Radius of the second coordination sphere equal to $r_2 = 0,244 \text{ nm}$ which could be able to interpret as the distance Ga-S. The ionic radii of gallium and sulfur atoms constitute $r_{\text{Ga}} = 0,127$ and $r_{\text{S}} = 0,104 \text{ nm}$, for which coordination number is six.

Meaning coordination number equal to $n_2 = 6,3$ received by us from calculating the area of the second peak on (FARD) CuGaS_2 also indicates the octahedral environment of gallium atoms by sulfur atoms.

The bond length between the atoms equal to $r_3 = 0,282 \text{ nm}$ corresponds to the distance between the same atoms Ga-Ga. Fourth maximum detected at a distance $r_4 = 0,411 \text{ nm}$ can be referred to the distance between the negatively charged divalent atoms (S^{2-}).

Comment [u5]: Fig. 3.

It should be noted that on (FARD) CuGaS_2 arise false details too, and ~~they~~ **its** may arise due to errors in the experimental intensity curve or cliff: they are mainly manifested in the large values of S and belong to groups with slightly blurred large coordination number equal to 8, 10 and 12.

During the deposition of this ternary compound on the substrate with $T_s = 423$ - 433 K a mixture of polycrystalline with single crystal is formed (Fig. 4.).

On the electronograms from the shown mixture appear more additional weaker reflexes. As a result of increase in temperature intensity polycrystalline lines are reduced but the intensity of point reflections corresponding to single crystal grow.

Further increase of the substrate temperature to 453 K LiF leads to the formation of a perfect single crystal. On electron diffraction from single crystals (Fig. 5), discontinued at right angles strong point reflexes, forming a square grid displayed on the basis of $hk0$ reflexes known lattice CuGaS_2 . Indexing of all reflexes, including additional low in intensity lines is achieved with parameter $a = 1.605$ nm.

Period "c", established by electron diffraction, shot at an angle $\varphi = 35^\circ$ was found to be 2.102 nm.

Between periods of lattices of the initial phase and superstructure there are simple relations common with: $a \approx 3a_0$; $c \approx 2c_0$. In the electron derived from film on substrates formulated with higher temperatures ($T_s = 473$ K), dynamic effects appear (Figure 6.). The microstructure of single crystal layers CuGaS_2 from which there is a dynamic high energy electron scattering is shown in Fig. 7 (X 20000). Thus, substrates can be LiF CuGaS_2 samples with varying subst

Comment [u6]: Fig. 3

120 ructure including a super lattice phase super period. Growth mechanism of single-crystal
 121 thin - film and nano scale epitaxial films is a model for many heterogeneous and
 122 topochemical processes.
 123 However, the existing theory of crystallization cannot explain all of the results of a large a
 124 mount of experimental work -
 125 there is a clear discrepancy between the flow :The totality of new facts and their level of
 126 theoretical understanding of the experimentally observed facts with a unified position
 127 cannot be considered. In existing theories of crystallization there is still no consensus on
 128 what is the main factor in orienting epitaxial.
 129 Generally accepted explanation is not considered as such a statement and that the main
 130 factor in orienting epitaxial is a single-crystal structure -
 131 substrates. Focused on the growth of amorphous boundary layers prepared on the surface
 132 of the substrate crystals [6,7] , is proof that the basic structure of crystals does not
 133 determine substrate orientation effects .
 134 Oriented crystallization on the outside boundary of polycrystalline layers [8-
 135 9] , as well as the growth of not only epitaxial films , but also highly perfect single
 136 crystals through the amorphous boundary
 137 layers [10] makes relate to the theory of crystallization based on the structure of single-
 138 crystal substrates seeds very carefully. Since many experimental
 139 works performed revealed a clear discrepancy between the facts and their level
 140 of theoretical understanding, it is not yet possible to formulate some general criteria for the
 141 formation of epitaxial films and single crystal. Therefore, conditions for the
 142 formation of single-crystal films to day, as shown in the previous chapter, are
 143 established only experimentally.

Since the bulk crystal lattice CuGaS_2 is ordered, in order to explain the formation of super lattice phase we should assume that it is the disordered phase. Disorder of ordered - structures some of the initial of the atoms in it are defective, resulting superstructure should have a statistical average frequency. Regularities of similar phase transitions were first established for the phases of the chemical group of compounds $\text{A}^3\text{B}^3\text{C}^6_2$ [4].

Superstructure phase CuGaS_2 is oriented (100) plane parallel to the faces [11] LiF. During epitaxial growth on LiF CuGaS_2 one unit cell (UC) superstructure is mated with four cells of the substrate. Relative discrepancy mating crystal lattices in this case is 2,9%.

4. Conclusions.

In CuGaS_2 amorph layers short range order parameters have been studied and it is shown that distance $r_1 = 0,234$ nm revealed on (FARD) CuGaS_2 , is the distance between atoms Cu-S, as tetrahedral covalent radii are equal to $r_{\text{Cu}} = 0,135$ and $r_{\text{S}} = 0,104$ nm. Appropriate coordination number $n = 4,1$ obtained from calculating the area under the first peak, also indicates tetrahedral surrounded by atoms of copper and gallium.

Radius of the second coordination sphere equal to $r_2 = 0,244$ nm which could be able to interpret as the distance Ga-S. The ionic radii of gallium and sulfur atoms constitute $r_{\text{Ga}} = 0,127$ and $r_{\text{S}} = 0,104$ nm, for which coordination number is six.

Meaning coordination number equal to $n_2 = 6,3$ received by us from calculating

the area of the second peak on (FARD) CuGaS₂ also indicates the octahedral environment of gallium atoms by sulfur atoms. It is shown that thin films on different substrates crystalize after thermal processing. During the deposition of this ternary compound on the substrate with $T_s = 423-433$ K a mixture of polycrystalline with single crystal is formed. Further increase of the substrate temperature to 453 K LiF leads to the formation of a perfect single crystal. Superstructure phase CuGaS₂ is oriented (100) plane parallel to the faces [11] LiF. During epitaxial growth on LiF CuGaS₂ one unit cell (UC) superstructure is mated with four cells of the substrate. Relative discrepancy mating crystal lattices in this case is 2,9%. It is found that between periods of lattices of the initial phase and superstructure there are simple relations common with: $a \approx 3a_0$; $c \approx 2c_0$.

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Figures of ELECTRON DIFFRACTION AND ELECTRON MICROSCOPY STUDY OF FILMS CuGaS_2 .

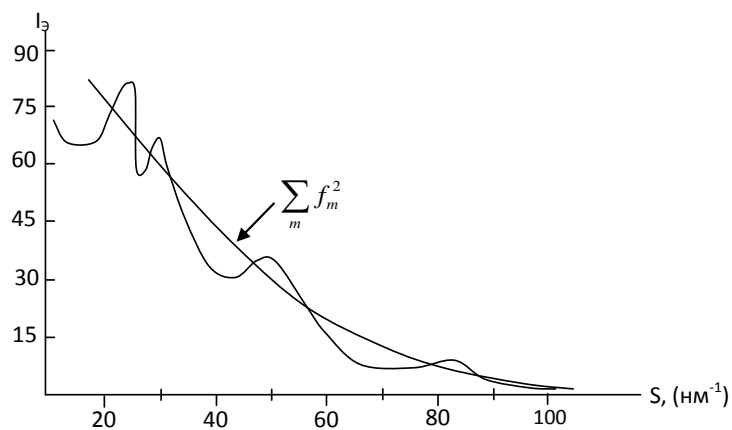


Fig.1.

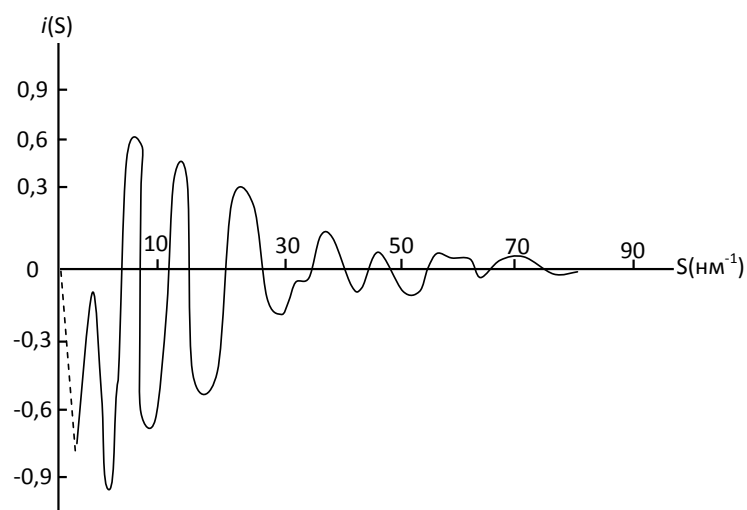


Fig.2.

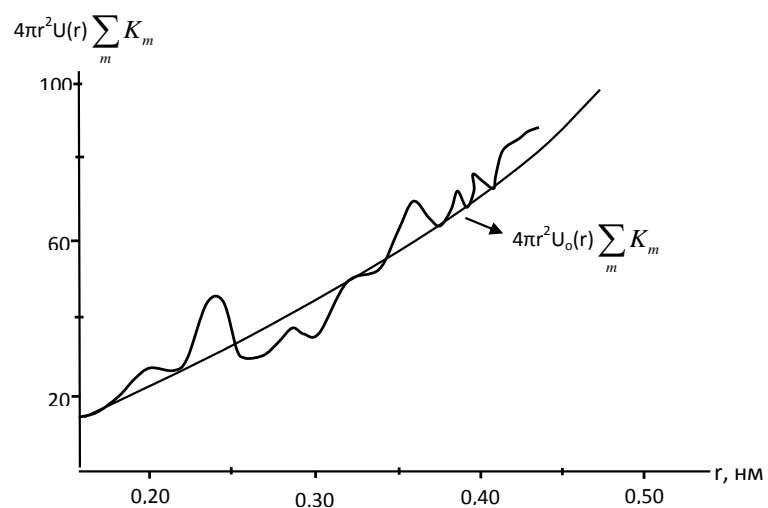


Figure 3.

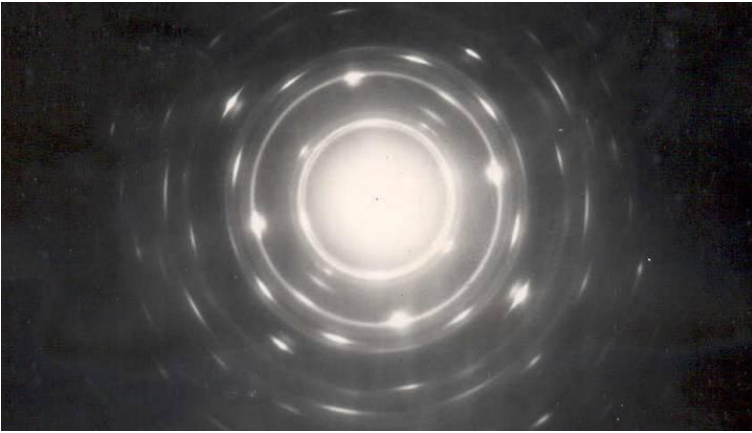


Fig. 4.

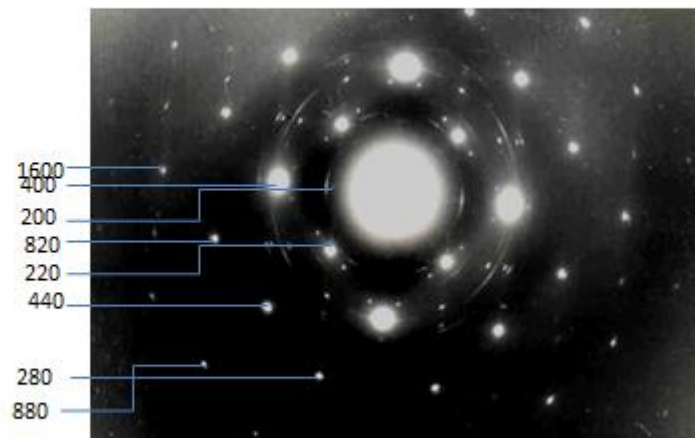


Fig.5

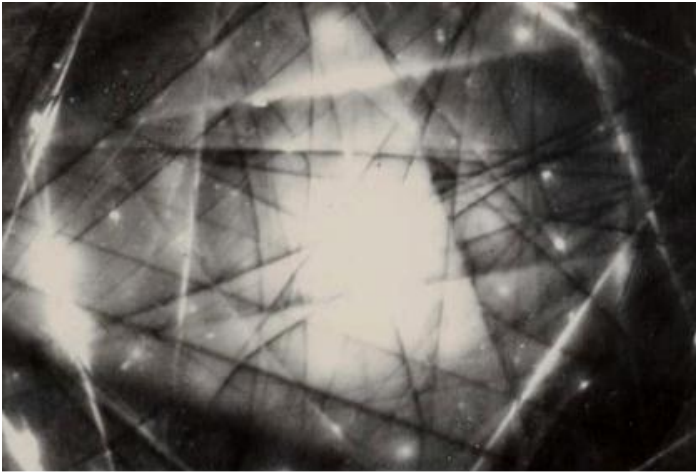


Fig.6.

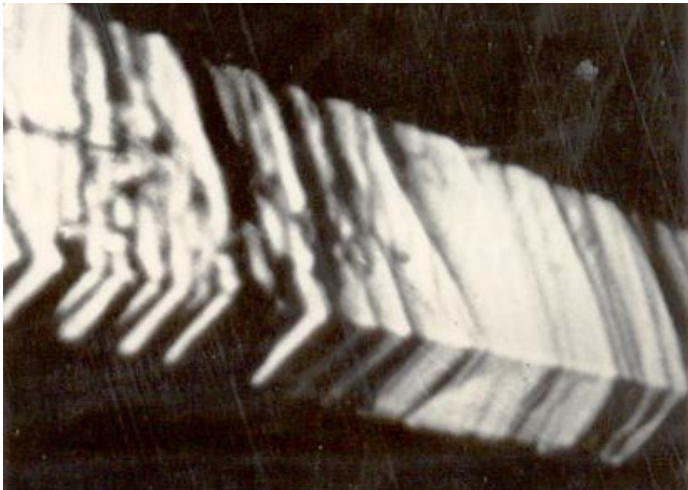


Fig.7.

Captions to figures of **ELECTRON DIFFRACTION AND ELECTRON
MICROSCOPY STUDY OF FILMS CuGaS_2 .**

Fig.1. The intensity curves of amorphous CuGaS_2 .

Fig.2. Interference scattering function of electrons of amorphous CuGaS_2

Fig.3. The curve of radial distribution of atoms of CuGaS_2

Fig. 4. Electron diffraction single crystal mixture with polycrystalline CuGaS_2

Fig.5. Electron diffraction from single crystal super lattice phase CuGaS_2

Fig.6. Electron diffraction pattern with Kikuchi lines from

single crystal CuGaS_2 high perfection.

Fig. 7. The microstructure of single-crystal beds of CuGaS_2 (H20000) .